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U.S. PATENT DOCUMENTS								
EXAMINER'S		*ISSUE			T		FIL	ING
INITIALS	*PATENT NO. 4,184,945	01/1980	*INVENTOR NAME Morgan et al.		CLASS	SUBCLASS	DA	TE
W	4,282,416	08/1981	White		219 219	757 756		-
~	4,313,043	01/1982	White et al.		219	756		
and a	4,618,756	10/1986	Sehwaderer et	al	219	757 dun	li =	tt
~	5,442,161	08/1995	Matsushima		219	756	440	/
				===	217	750		
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U.S. PATENT APPLICATION PUBLICATIONS								
	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT		CLASS	SUBCLASS		
				·				
U.S. PATENT APPLICATIONS								
	*APPLN. NO.	*FILING DATE	*INV	ENTOR	CLASS	SUBCLASS		
FOREIGN PATENT DOCUMENTS								
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY		CLASS	SUBCLASS	Trans Yes	ation No
M	0110364	06/1984	Europe		219	756		
\sim	58-203322	11/1983	Japan		219	756		
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OIH	EK AKT (Includir	ng Author, Tit	le, Date, Pertine	nt Pages, Publishe	r, Place of	Publication, E	tc.)	
	PECTIVE							
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JUN 1 9 7003								
TECHNOLOGY CENTER R3700								
EXAMINER PHILIP H. LEUNG DATE CONSIDERED 8-19-03								